

Notice of References Cited	Application/Control No. 10/689,499		Applicant(s)/Patent Under Reexamination BAARMAN, DAVID W.	
	Examiner Y. J. Han		Art Unit 2838	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,796,334	08-1998	Chen et al.	324/429
	B	US-			
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	D	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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